| | Application No. | Applicant(s) |
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| Notice of Allowability | | |
| | 10/699,937 Examiner | UCHIDA ET AL. Art Unit |
| • | | |
| | TAN X. DINH | 2653 |
| The MAILING DATE of this communication appear All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313 | (OR REMAINS) CLOSED in to other appropriate communication is sufficient. | this application. If not included nication will be mailed in due course. THIS |
| 1. This communication is responsive to 7/07/2005. | | |
| 2. The allowed claim(s) is/are 1.3.4.68-15 (renumber as 1-12 | <u>)</u> . | |
| 3. \boxtimes The drawings filed on <u>03 November 2003</u> are accepted by | the Examiner. | |
| 4. Acknowledgment is made of a claim for foreign priority ur a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: | been received. been received in Application | No. <u>10/038,189</u> . |
| Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. | of this communication to file a IENT of this application. | reply complying with the requirements |
| A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give | itted. Note the attached EXANes reason(s) why the oath or c | MINER'S AMENDMENT or NOTICE OF leclaration is deficient. |
| 6. CORRECTED DRAWINGS (as "replacement sheets") muss (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date Identifying Indicla such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the state of the placement sheet (s) should be labeled as such in the state of the placement sheet (s) should be labeled as such in the placement sheet (s) should be labeled as such as the placement sheet (s) should be labeled as such as the placement sheet (s) should be labeled as such as the placement sheet (s) should be labeled as such as the placement sheet (s) should be labeled as such as the placement sheet (s) should be labeled | on's Patent Drawing Review of the second of | n the Office action of drawings in the front (not the back) of |
| DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT | SIT OF BIOLOGICAL MATER FOR THE DEPOSIT OF BIOL | RIAL must be submitted. Note the OGICAL MATERIAL. |
| Attachment(s) 1. ☐ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date | 6. ☐ Interview Sun Paper No./M 8), 7. ☐ Examiner's A | rmal Patent Application (PTO-152) nmary (PTO-413), lail Date mendment/Comment tatement of Reasons for Allowance |
| | | TAN Xuan DINH Primary Examiner Art Unit: 2653 |

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1) The Terminal Disclaimer filed 7/07/2005 has been approved and recorded in the file.

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- 2) The amendment filed 7/07/2005 is acknowledged. Claims 2,5,7 and 16-18 have been canceled.
 - 3) Claims 1,3,4,6,8-15 are allowed.

The optical disk comprising a substrate and a recording layer disposed above the substrate and reproducing an information signal by a DWDD system using light incident from the substrate side, the optical disk further comprising a first dielectric layer disposed between the substrate a recording layer, a second dielectric layer disposed on the recording layer opposite to the substrate, wherein magnetic coupling of a part of the recording layer is weakened by irradiation with light having a wavelength λ incident from the second dielectric layer side and the thickness of the second dielectric layer is in a range of $\lambda/(12 \times n)$ to $\lambda/(2 \times n)$, where n is a refractive index of the second dielectric layer, as recited in the independent claims, are not found or suggested in the prior art of record.

4) Any inquiry concerning this communication or earlier communications from the examiner should be directed to Primary Examiner TAN X. DINH whose telephone number is (571)273-8300. The examiner can normally be reached on Monday-Friday from 8:00AM to 5:00PM.

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The fax phone number for the organization where this application or proceeding is assigned is (571)273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov/. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

TAN DINH
PRIMARY EXAMINER
July 25, 2005